

# NB6L11S

## 2.5 V 1:2 AnyLevel™ Input to LVDS Fanout Buffer / Translator

The NB6L11S is a differential 1:2 Clock or Data Receiver and will accept AnyLevel™ input signals: LVPECL, CML, LVCMOS, LVTTTL, or LVDS. These signals will be translated to LVDS and two identical copies of Clock or Data will be distributed, operating up to 2.0 GHz or 2.5 Gb/s, respectively. As such, the NB6L11S is ideal for SONET, GigE, Fiber Channel, Backplane and other Clock or Data distribution applications.

The NB6L11S has a wide input common mode range from  $GND + 50\text{ mV}$  to  $V_{CC} - 50\text{ mV}$ . Combined with the  $50\ \Omega$  internal termination resistors at the inputs, the NB6L11S is ideal for translating a variety of differential or single-ended Clock or Data signals to 350 mV typical LVDS output levels.

The NB6L11S is the 2.5 V version of the NB6N11S and is offered in a small 3 mm X 3 mm 16-QFN package. Application notes, models, and support documentation are available at [www.onsemi.com](http://www.onsemi.com).

### Features

- Maximum Input Clock Frequency > 2.0 GHz
- Maximum Input Data Rate > 2.5 Gb/s
- 1 ps Maximum of RMS Clock Jitter
- Typically 10 ps of Data Dependent Jitter
- 380 ps Typical Propagation Delay
- 120 ps Typical Rise and Fall Times
- Single Power Supply;  $V_{CC} = 2.5\text{ V} \pm 5\%$
- These are Pb-Free Devices

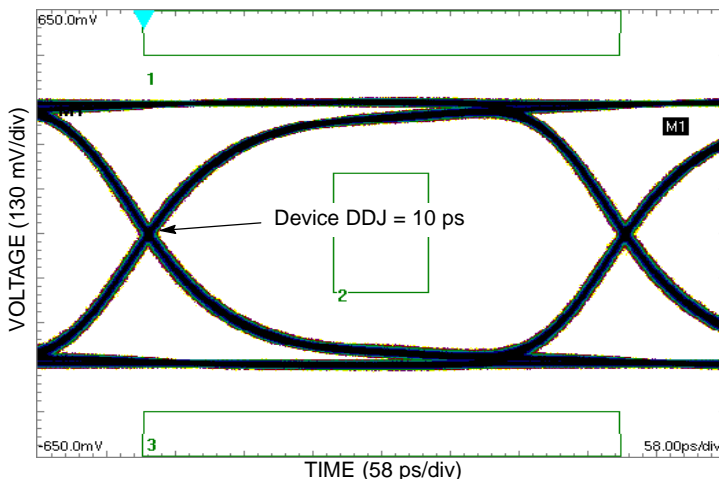


Figure 2. Typical Output Waveform at 2.488 Gb/s with PRBS  $2^{23}-1$  ( $V_{INPP} = 400\text{ mV}$ ; Input Signal DDJ = 14 ps)



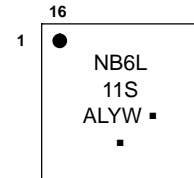
ON Semiconductor®

<http://onsemi.com>

### MARKING DIAGRAM\*



QFN-16  
MN SUFFIX  
CASE 485G



A = Assembly Location  
L = Wafer Lot  
Y = Year  
W = Work Week  
▪ = Pb-Free Package

(Note: Microdot may be in either location)

\*For additional marking information, refer to Application Note AND8002/D.

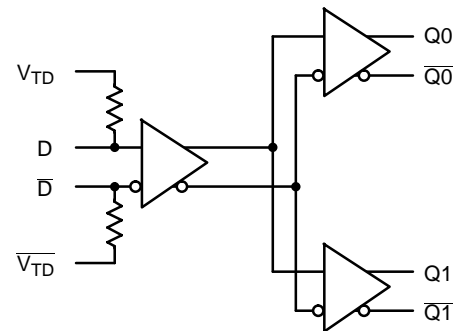


Figure 1. Logic Diagram

### ORDERING INFORMATION

See detailed ordering and shipping information in the package dimensions section on page 9 of this data sheet.

# NB6L11S

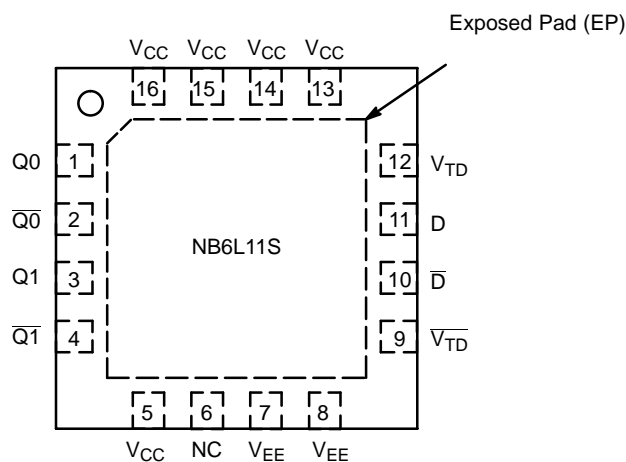


Figure 3. NB6L11S Pinout, 16-pin QFN (Top View)

Table 1. PIN DESCRIPTION

| Pin | Name             | I/O                               | Description   |
|-----|------------------|-----------------------------------|---|
| 1   | Q0               | LVDS Output                       | Non-inverted D output. Typically loaded with 100 Ω receiver termination resistor across differential pair.  |
| 2   | $\overline{Q0}$  | LVDS Output                       | Inverted D output. Typically loaded with 100 Ω receiver termination resistor across differential pair.  |
| 3   | Q1               | LVDS Output                       | Non-inverted D output. Typically loaded with 100 Ω receiver termination resistor across differential pair.  |
| 4   | $\overline{Q1}$  | LVDS Output                       | Inverted D output. Typically loaded with 100 Ω receiver termination resistor across differential pair.  |
| 5   | V <sub>CC</sub>  | –                                 | Positive Supply Voltage.  |
| 6   | NC               | –                                 | No Connect.   |
| 7   | V <sub>EE</sub>  | –                                 | Negative Supply Voltage.  |
| 8   | V <sub>EE</sub>  | –                                 | Negative Supply Voltage.  |
| 9   | $\overline{VTD}$ | –                                 | Internal 50 Ω termination pin for $\overline{D}$ .  |
| 10  | $\overline{D}$   | LVPECL, CML, LVDS, LVCMOS, LVTTTL | Inverted Differential Clock/Data Input (Note 1).  |
| 11  | D                | LVPECL, CML, LVDS, LVCMOS, LVTTTL | Non-inverted Differential Clock/Data Input (Note 1).  |
| 12  | V <sub>TD</sub>  | –                                 | Internal 50 Ω termination pin for $\overline{D}$ .  |
| 13  | V <sub>CC</sub>  | –                                 | Positive Supply Voltage.  |
| 14  | V <sub>CC</sub>  | –                                 | Positive Supply Voltage.  |
| 15  | V <sub>CC</sub>  | –                                 | Positive Supply Voltage.  |
| 16  | V <sub>CC</sub>  | –                                 | Positive Supply Voltage.  |
| EP  |                  |                                   | Exposed pad. The exposed pad (EP) on the package bottom must be attached to a heat-sinking conduit. The exposed pad may only be electrically connected to V <sub>EE</sub> . |

1. In the differential configuration when the input termination pins (VTD0/VTD0, VTD1/ VTD1) are connected to a common termination voltage or left open, and if no signal is applied on D0/ $\overline{D0}$ , D1/ $\overline{D1}$  input, then the device will be susceptible to self-oscillation.

# NB6L11S

**Table 2. ATTRIBUTES**

| Characteristic   | Value   |
|--|---|
| ESD Protection   | Human Body Model<br>Machine Model<br>Charged Device Model |
|  | > 2 kV<br>> 200 V<br>> 1 kV                               |
| Moisture Sensitivity (Note 2)                          | Pb-Free Pkg   |
|  | QFN-16  |
|  | Level 1   |
| Flammability Rating Oxygen Index: 28 to 34             | UL 94 V-0 @ 0.125 in                                      |
| Transistor Count                                       | 225   |
| Meets or exceeds JEDEC Spec EIA/JESD78 IC Latchup Test |   |

2. For additional information, see Application Note AND8003/D.

**Table 3. MAXIMUM RATINGS**

| Symbol        | Parameter   | Condition 1                     | Condition 2              | Rating       | Unit                             |
|---------------|---|---------------------------------|--------------------------|--------------|----------------------------------|
| $V_{CC}$      | Positive Power Supply   | GND = 0 V                       |                          | 3.8          | V                                |
| $V_{IN}$      | Positive Input  | GND = 0 V                       | $V_{IN} \leq V_{CC}$     | 3.8          | V                                |
| $I_{IN}$      | Input Current Through $R_T$ (50 $\Omega$ Resistor)  | Static<br>Surge                 |                          | 35<br>70     | mA<br>mA                         |
| $I_{OSC}$     | Output Short Circuit Current<br>Line-to-Line (Q to $\bar{Q}$ )<br>Line-to-End (Q or $\bar{Q}$ to GND) | Q or $\bar{Q}$ to GND<br>Q to Q | Continuous<br>Continuous | 12<br>24     | mA                               |
| $T_A$         | Operating Temperature Range   | QFN-16                          |                          | -40 to +85   | $^{\circ}$ C                     |
| $T_{stg}$     | Storage Temperature Range   |                                 |                          | -65 to +150  | $^{\circ}$ C                     |
| $\theta_{JA}$ | Thermal Resistance (Junction-to-Ambient) (Note 3)   | 0 lfpm<br>500 lfpm              | QFN-16<br>QFN-16         | 41.6<br>35.2 | $^{\circ}$ C/W<br>$^{\circ}$ C/W |
| $\theta_{JC}$ | Thermal Resistance (Junction-to-Case)   | 1S2P (Note 3)                   | QFN-16                   | 4.0          | $^{\circ}$ C/W                   |
| $T_{sol}$     | Wave Solder   | Pb-Free                         |                          | 265          | $^{\circ}$ C                     |

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

3. JEDEC standard multilayer board – 1S2P (1 signal, 2 power) with 8 filled thermal vias under exposed pad.

# NB6L11S

**Table 4. DC CHARACTERISTICS, CLOCK INPUTS, LVDS OUTPUTS**  $V_{CC} = 2.375 \text{ V to } 2.625 \text{ V}$ ,  $GND = 0 \text{ V}$ ,  
 $T_A = -40^\circ\text{C to } +85^\circ\text{C}$

| Symbol   | Characteristic                | Min | Typ | Max | Unit |
|----------|-------------------------------|-----|-----|-----|------|
| $I_{CC}$ | Power Supply Current (Note 8) |     | 30  | 45  | mA   |

### DIFFERENTIAL INPUTS DRIVEN SINGLE-ENDED (Figures 11, 12, 16, and 18)

|          |  |                |  |                |    |
|----------|--|----------------|--|----------------|----|
| $V_{th}$ | Input Threshold Reference Voltage Range (Note 7) | GND +100       |  | $V_{CC} - 100$ | mV |
| $V_{IH}$ | Single-ended Input HIGH Voltage                  | $V_{th} + 100$ |  | $V_{CC}$       | mV |
| $V_{IL}$ | Single-ended Input LOW Voltage                   | GND            |  | $V_{th} - 100$ | mV |

### DIFFERENTIAL INPUTS DRIVEN DIFFERENTIALLY (Figures 7, 8, 9, 10, 17, and 19)

|           |  |          |    |                |          |
|-----------|--|----------|----|----------------|----------|
| $V_{IHD}$ | Differential Input HIGH Voltage                      | 100      |    | $V_{CC}$       | mV       |
| $V_{ILD}$ | Differential Input LOW Voltage                       | GND      |    | $V_{CC} - 100$ | mV       |
| $V_{CMR}$ | Input Common Mode Range (Differential Configuration) | GND + 50 |    | $V_{CC} - 50$  | mV       |
| $V_{ID}$  | Differential Input Voltage ( $V_{IHD} - V_{ILD}$ )   | 100      |    | $V_{CC}$       | mV       |
| $R_{TIN}$ | Internal Input Termination Resistor                  | 40       | 50 | 60             | $\Omega$ |

### LVDS OUTPUTS (Note 4)

|                 |  |      |      |      |    |
|-----------------|--|------|------|------|----|
| $V_{OD}$        | Differential Output Voltage  | 250  |      | 450  | mV |
| $\Delta V_{OD}$ | Change in Magnitude of $V_{OD}$ for Complementary Output States (Note 9) | 0    | 1    | 25   | mV |
| $V_{OS}$        | Offset Voltage (Figure 15)   | 1125 |      | 1375 | mV |
| $\Delta V_{OS}$ | Change in Magnitude of $V_{OS}$ for Complementary Output States (Note 9) | 0    | 1    | 25   | mV |
| $V_{OH}$        | Output HIGH Voltage (Note 5)   |      | 1425 | 1600 | mV |
| $V_{OL}$        | Output LOW Voltage (Note 6)  | 900  | 1075 |      | mV |

NOTE: Device will meet the specifications after thermal equilibrium has been established when mounted in a test socket or printed circuit board with maintained transverse airflow greater than 500 lfm. Electrical parameters are guaranteed only over the declared operating temperature range. Functional operation of the device exceeding these conditions is not implied. Device specification limit values are applied individually under normal operating conditions and not valid simultaneously.

4. LVDS outputs require 100  $\Omega$  receiver termination resistor between differential pair. See Figure 14.
5.  $V_{OHmax} = V_{OSmax} + \frac{1}{2} V_{ODmax}$ .
6.  $V_{OLmax} = V_{OSmin} - \frac{1}{2} V_{ODmax}$ .
7.  $V_{th}$  is applied to the complementary input when operating in single-ended mode.
8. Input termination pins open, D/ $\bar{D}$  at the DC level within  $V_{CMR}$  and output pins loaded with  $R_L = 100 \Omega$  across differential.
9. Parameter guaranteed by design verification not tested in production.

# NB6L11S

**Table 5. AC CHARACTERISTICS**  $V_{CC} = 2.375\text{ V to }2.625\text{ V}$ ,  $GND = 0\text{ V}$ ; (Note 10)

| Symbol                   | Characteristic  | -40°C        |                            |                 | 25°C |                            |                 | 85°C |                            |                 | Unit |    |
|--------------------------|---|--------------|----------------------------|-----------------|------|----------------------------|-----------------|------|----------------------------|-----------------|------|----|
|                          |   | Min          | Typ                        | Max             | Min  | Typ                        | Max             | Min  | Typ                        | Max             |      |    |
| $V_{OUTPP}$              | Output Voltage Amplitude (@ $V_{INPPmin}$ )<br>(Figure 4)<br>$f_{in} \leq 1.0\text{ GHz}$<br>$f_{in} = 1.5\text{ GHz}$<br>$f_{in} = 2.0\text{ GHz}$   | 220          | 350                        |                 | 220  | 350                        |                 | 220  | 350                        |                 | mV   |    |
| $f_{DATA}$               | Maximum Operating Data Rate   | 1.5          | 2.5                        |                 | 1.5  | 2.5                        |                 | 1.5  | 2.5                        |                 | Gb/s |    |
| $t_{PLH}$ ,<br>$t_{PHL}$ | Differential Input to Differential Output<br>Propagation Delay  | 250          |                            | 450             | 250  |                            | 450             | 250  |                            | 450             | ps   |    |
| $t_{SKEW}$               | Duty Cycle Skew (Note 11)<br>Within Device Skew (Note 16)<br>Device-to-Device Skew (Note 15)  |              | 8<br>5<br>30               | 45<br>25<br>100 |      | 8<br>5<br>30               | 45<br>25<br>100 |      | 8<br>5<br>30               | 45<br>25<br>100 | ps   |    |
| $t_{JITTER}$             | RMS Random Clock Jitter (Note 13)<br>Deterministic Jitter (Note 14)<br>$f_{in} = 1.0\text{ GHz}$<br>$f_{in} = 1.5\text{ GHz}$<br>$f_{DATA} = 622\text{ Mb/s}$<br>$f_{DATA} = 1.5\text{ Gb/s}$<br>$f_{DATA} = 2.488\text{ Gb/s}$ |              | 0.5<br>0.5<br>6<br>7<br>10 |                 |      | 0.5<br>0.5<br>6<br>7<br>10 |                 |      | 0.5<br>0.5<br>6<br>7<br>10 |                 | ps   |    |
| $V_{INPP}$               | Input Voltage Swing/Sensitivity<br>(Differential Configuration) (Note 12)   | 100          |                            | $V_{CC} - GND$  | 100  |                            | $V_{CC} - GND$  | 100  |                            | $V_{CC} - GND$  | mV   |    |
| $t_r$<br>$t_f$           | Output Rise/Fall Times @ 250 MHz<br>(20% – 80%)   | $Q, \bar{Q}$ | 70                         | 120             | 170  | 70                         | 120             | 170  | 70                         | 120             | 170  | ps |

NOTE: Device will meet the specifications after thermal equilibrium has been established when mounted in a test socket or printed circuit board with maintained transverse airflow greater than 500 lpm. Electrical parameters are guaranteed only over the declared operating temperature range. Functional operation of the device exceeding these conditions is not implied. Device specification limit values are applied individually under normal operating conditions and not valid simultaneously.

10. Measured by forcing  $V_{INPPmin}$  with 50% duty cycle clock source and  $V_{CC} - 1400\text{ mV}$  offset. All loading with an external  $R_L = 100\ \Omega$  across "D" and  $\bar{D}$  of the receiver. Input edge rates 150 ps (20%–80%).

11. See Figure 13 differential measurement of  $t_{skew} = |t_{PLH} - t_{PHL}|$  for a nominal 50% differential clock input waveform @ 250 MHz.

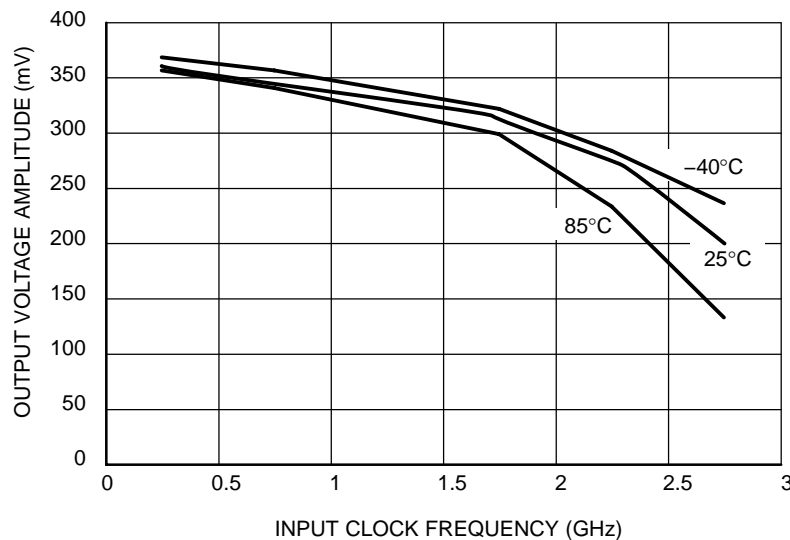
12. Input voltage swing is a single-ended measurement operating in differential mode.

13. RMS jitter with 50% Duty Cycle input clock signal.

14. Deterministic jitter with input NRZ data at PRBS  $2^{23}-1$  and K28.5.

15. Skew is measured between outputs under identical transition @ 250 MHz.

16. The worst case condition between  $Q0/Q\bar{0}$  and  $Q1/Q\bar{1}$  from either  $D0/D\bar{0}$  or  $D1/D\bar{1}$ , when both outputs have the same transition.



**Figure 4. Output Voltage Amplitude ( $V_{OUTPP}$ ) versus Input Clock Frequency ( $f_{in}$ ) and Temperature (@  $V_{CC} = 2.5\text{ V}$ )**

# NB6L11S

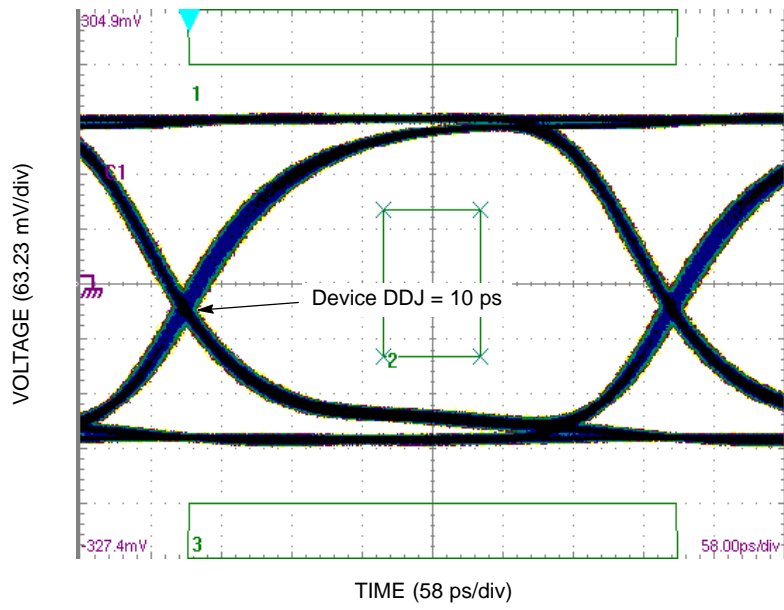


Figure 5. Typical Output Waveform at 2.488 Gb/s with PRBS  $2^{23}-1$  and OC48 mask ( $V_{INPP} = 100$  mV; Input Signal DDJ = 14 ps)

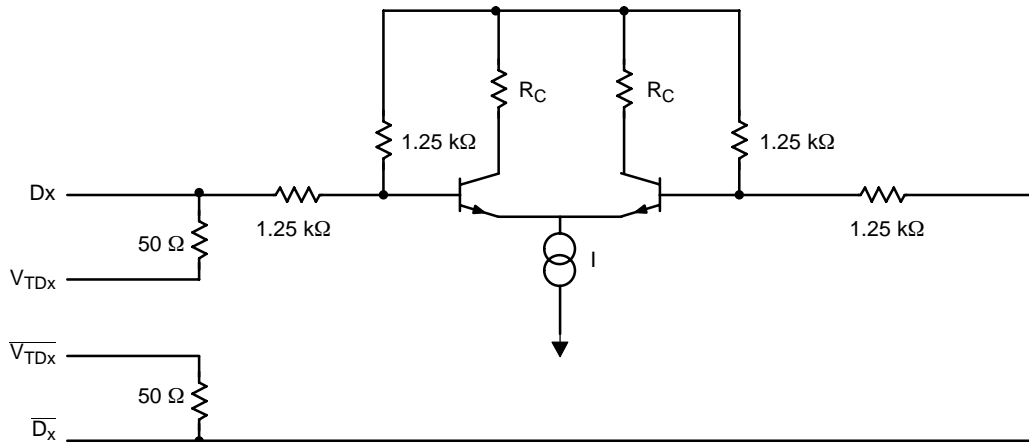


Figure 6. Input Structure

# NB6L11S

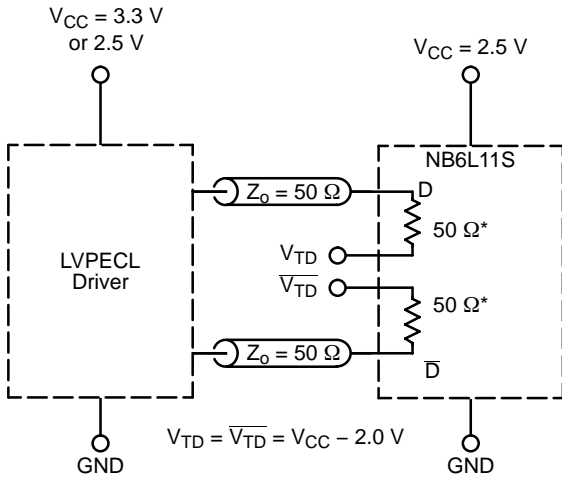


Figure 7. LVPECL Interface

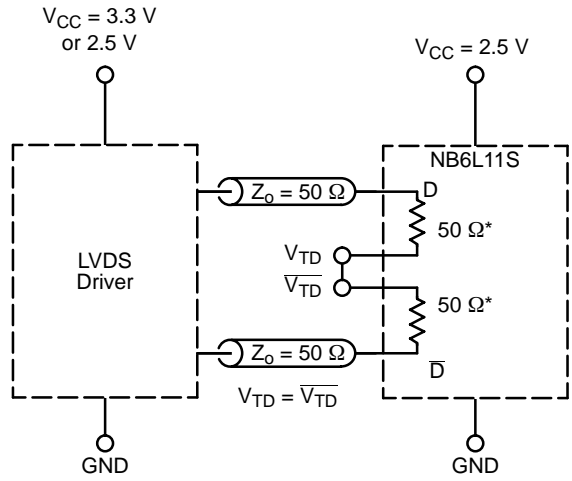


Figure 8. LVDS Interface

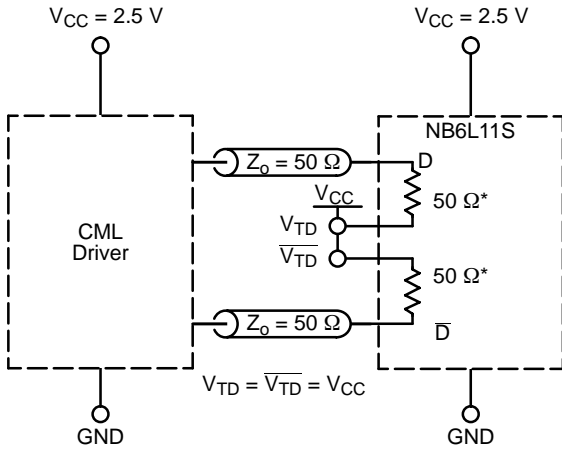


Figure 9. Standard 50 Ω Load CML Interface

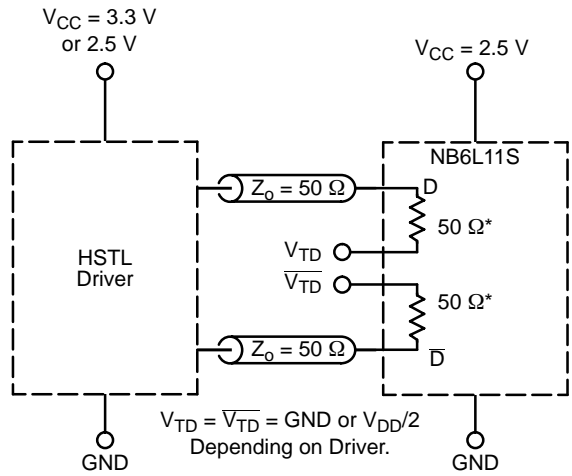


Figure 10. HSTL Interface

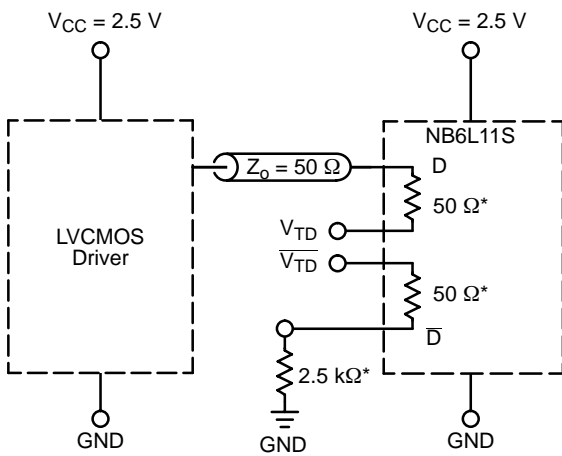


Figure 11. LVCMOS Interface

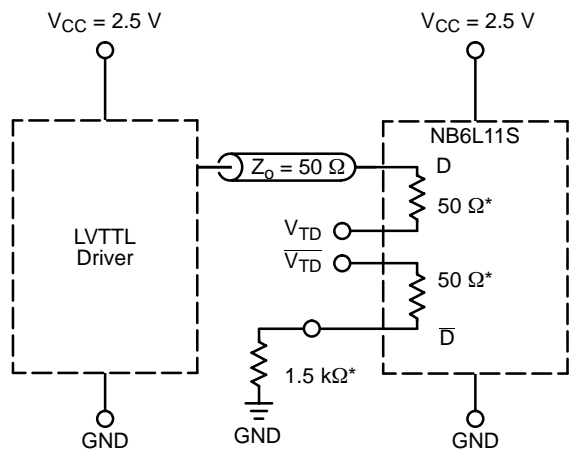


Figure 12. LVTTTL Interface

\* $R_{TIN}$ , Internal Input Termination Resistor.

# NB6L11S

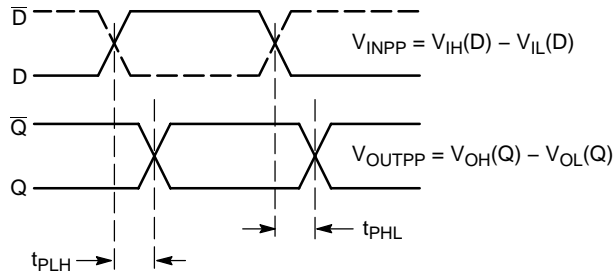


Figure 13. AC Reference Measurement

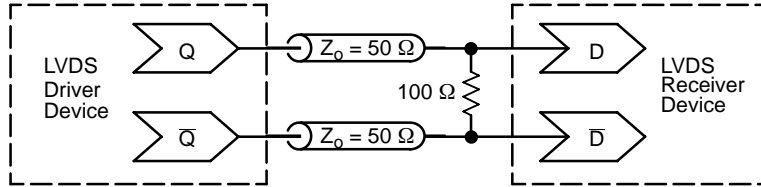


Figure 14. Typical LVDS Termination for Output Driver and Device Evaluation

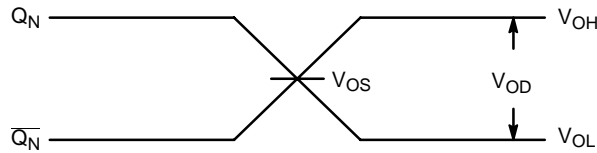


Figure 15. LVDS Output

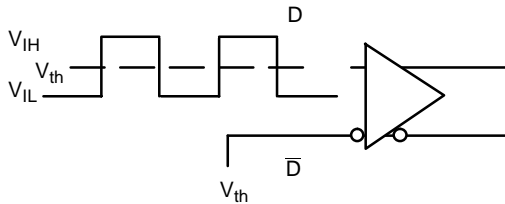


Figure 16. Differential Input Driven Single-Ended

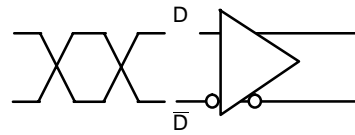


Figure 17. Differential Inputs Driven Differentially

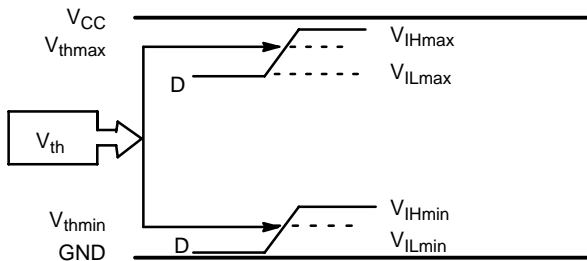


Figure 18.  $V_{th}$  Diagram

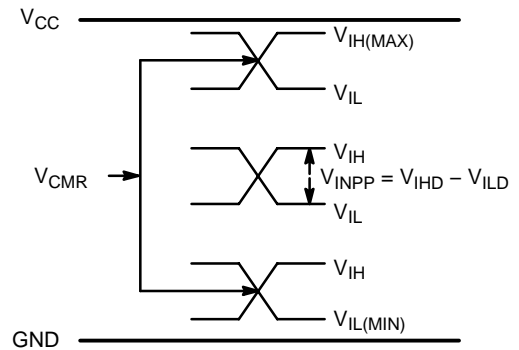


Figure 19.  $V_{CMR}$  Diagram



# NB6L11S

## ORDERING INFORMATION

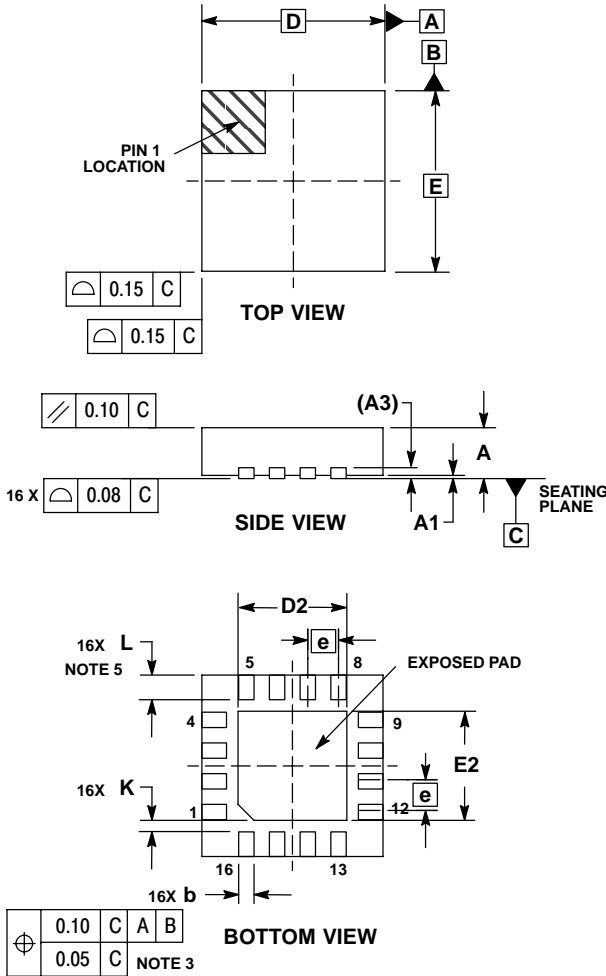
| Device       | Package                       | Shipping†          |
|--------------|-------------------------------|--------------------|
| NB6L11SMNG   | QFN-16, 3 X 3 mm<br>(Pb-Free) | 123 Units / Rail   |
| NB6L11SMNR2G | QFN-16, 3 X 3 mm<br>(Pb-Free) | 3000 / Tape & Reel |

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

# NB6L11S

## PACKAGE DIMENSIONS

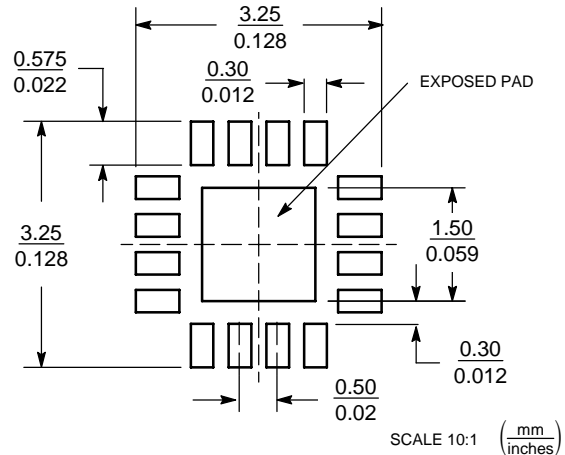
16 PIN QFN  
CASE 485G-01  
ISSUE C



- NOTES:
1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
  2. CONTROLLING DIMENSION: MILLIMETERS.
  3. DIMENSION b APPLIES TO PLATED TERMINAL AND IS MEASURED BETWEEN 0.25 AND 0.30 MM FROM TERMINAL.
  4. COPLANARITY APPLIES TO THE EXPOSED PAD AS WELL AS THE TERMINALS.
  5. L<sub>max</sub> CONDITION CAN NOT VIOLATE 0.2 MM MINIMUM SPACING BETWEEN LEAD TIP AND FLAG

| DIM | MILLIMETERS |      |
|-----|-------------|------|
|     | MIN         | MAX  |
| A   | 0.80        | 1.00 |
| A1  | 0.00        | 0.05 |
| A3  | 0.20 REF    |      |
| b   | 0.18        | 0.30 |
| D   | 3.00 BSC    |      |
| D2  | 1.65        | 1.85 |
| E   | 3.00 BSC    |      |
| E2  | 1.65        | 1.85 |
| e   | 0.50 BSC    |      |
| K   | 0.18 TYP    |      |
| L   | 0.30        | 0.50 |

### SOLDERING FOOTPRINT\*



\*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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- Экспресс доставка в любую точку России;
- Техническая поддержка проекта, помощь в подборе аналогов, поставка прототипов;
- Система менеджмента качества сертифицирована по Международному стандарту ISO 9001;
- Лицензия ФСБ на осуществление работ с использованием сведений, составляющих государственную тайну;
- Поставка специализированных компонентов (Xilinx, Altera, Analog Devices, Intersil, Interpoint, Microsemi, Aeroflex, Peregrine, Syfer, Eurofarad, Texas Instrument, Miteq, Cobham, E2V, MA-COM, Hittite, Mini-Circuits, General Dynamics и др.);

Помимо этого, одним из направлений компании «ЭлектроПласт» является направление «Источники питания». Мы предлагаем Вам помощь Конструкторского отдела:

- Подбор оптимального решения, техническое обоснование при выборе компонента;
- Подбор аналогов;
- Консультации по применению компонента;
- Поставка образцов и прототипов;
- Техническая поддержка проекта;
- Защита от снятия компонента с производства.



#### Как с нами связаться

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